Search Notes



Application/Control	No.
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10/622,937 Examiner

Hai L. Nguyen

Applicant(s)/Patent under Reexamination

SCHRODINGER, KARL Art Unit

2816

SEARCHED					
Class	Subclass	Date	Examiner		
327	165-167, 170,171, 105,141	4/13/2005	HLN		
327	291-299				
327	560-563				
326	28				
330	252,253				
330	259-261	1	1		

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
Above	4/13/2005	HLN			
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	Subclass	Subclass Date			

SEARCH NOT (INCLUDING SEARCH	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
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